

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1657		SERIAL NO. 09/905.320	
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary.)</small>				APPLICANT: Cem Basceri et al.			
				FILING DATE July 13, 2001		GROSS 1762	

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U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
EF	AA 09/932.003		Basceri			08/17/01	
EF	AB 6,337,496 B2	01/08/02	Jung				
EF	AC 6,507,060 B2	01/14/03	Ren et al.				
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Sheet 1 of 1

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						Yes	No
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EF	AM	DISSERTATION. Cem Basceri. <i>Electrical and Dielectric Properties of (Ba,Sr)TiO₃ Thin Film Capacitors for Ultra-High ...</i> 171 pages (North Carolina State University, Raleigh 1997).
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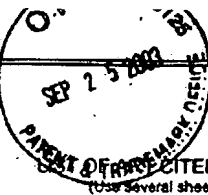
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*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
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EP	AC	5,711,816	01/27/98	Kirlin et al.			
	AB						
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	AE						
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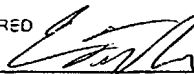
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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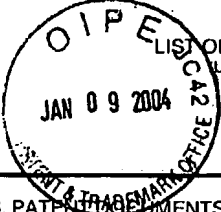
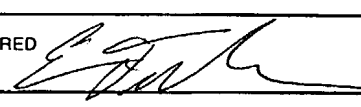
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*Examiner's Initials	AA	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
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EF	AB	6,527,028 B2	03/2003	Miller	156	555	
EF	AC	6,422,281 B1	07/2002	Ensign, Jr. et al.	156	495	
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EF	AF	5,635,741	06/1997	Tsu et al.	257	310	
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